

Search Notes

Application/Control No.

10/601,061

Examiner

Adolf Berhane

Applicant(s)/Patent under
Reexamination

WEI ET AL.

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
363	34		
	37		
	39		
	40		
	47		
	48	3/2/2005	AB

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner